

# MOSFET

Metal Oxide Semiconductor Field Effect Transistor

## CoolMOS™ C6

600V CoolMOS™ C6 Power Transistor  
IPx60R099C6

## Data Sheet

Rev. 2.3  
Final

## 600V CoolMOS™ C6 Power Transistor

IPA60R099C6, IPB60R099C6  
IPP60R099C6 IPW60R099C6

### 1 Description

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ C6 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The offered devices provide all benefits of a fast switching SJ MOSFET while not sacrificing ease of use. Extremely low switching and conduction losses make switching applications even more efficient, more compact, lighter, and cooler.

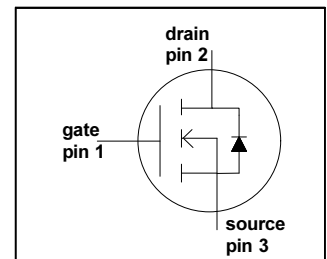
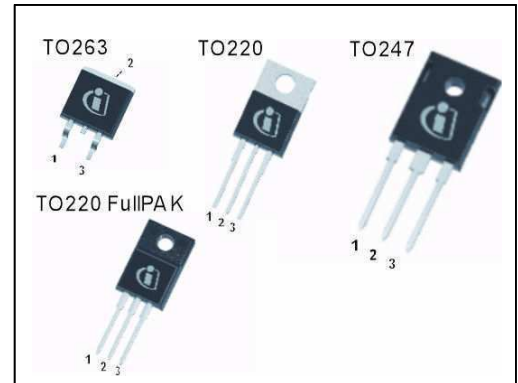
#### Features

- Extremely low losses due to very low FOM  $R_{DS(on)} \cdot Q_g$  and  $E_{oss}$
- Very high commutation ruggedness
- Easy to use/drive
- JEDEC<sup>1)</sup> qualified, Pb-free plating, Halogen free

#### Applications

PFC stages, hard switching PWM stages and resonant switching PWM stages for e.g. PC Silverbox, Adapter, LCD & PDP TV, Lighting, Server, Telecom and UPS.

Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



**Table 1 Key Performance Parameters**

| Parameter            | Value | Unit       |
|----------------------|-------|------------|
| $V_{DS} @ T_{j,max}$ | 650   | V          |
| $R_{DS(on),max}$     | 0.099 | $\Omega$   |
| $Q_{g,typ}$          | 119   | nC         |
| $I_{D,pulse}$        | 112   | A          |
| $E_{oss} @ 400V$     | 9.3   | $\mu J$    |
| Body diode $di/dt$   | 300   | A/ $\mu s$ |

| Type / Ordering Code | Package          | Marking | Related Links                                                                                                                                       |
|----------------------|------------------|---------|-----------------------------------------------------------------------------------------------------------------------------------------------------|
| IPW60R099C6          | PG-TO247         | 6R099C6 | <a href="#">IFX C6 Product Brief</a><br><a href="#">IFX C6 Portfolio</a><br><a href="#">IFX CoolMOS Webpage</a><br><a href="#">IFX Design tools</a> |
| IPB60R099C6          | PG-TO263         |         |                                                                                                                                                     |
| IPP60R099C6          | PG-TO220         |         |                                                                                                                                                     |
| IPA60R099C6          | PG-TO220 FullPAK |         |                                                                                                                                                     |

1) J-STD20 and JESD22

## Table of Contents

|   |                                           |    |
|---|-------------------------------------------|----|
| 1 | Description .....                         | 2  |
|   | Table of Contents .....                   | 3  |
| 2 | Maximum ratings .....                     | 4  |
| 3 | Thermal characteristics .....             | 5  |
| 4 | Electrical characteristics .....          | 6  |
| 5 | Electrical characteristics diagrams ..... | 8  |
| 6 | Test circuits .....                       | 13 |
| 7 | Package outlines .....                    | 14 |
| 8 | Revision History .....                    | 18 |

## 2 Maximum ratings

at  $T_j = 25\text{ °C}$ , unless otherwise specified.

**Table 2 Maximum ratings**

| Parameter                                     | Symbol         | Values |      |      | Unit | Note / Test Condition                                                     |
|-----------------------------------------------|----------------|--------|------|------|------|---------------------------------------------------------------------------|
|                                               |                | Min.   | Typ. | Max. |      |                                                                           |
| Continuous drain current <sup>1)</sup>        | $I_D$          | -      | -    | 37.9 | A    | $T_C = 25\text{ °C}$                                                      |
|                                               |                |        |      | 24   |      | $T_C = 100\text{ °C}$                                                     |
| Pulsed drain current <sup>2)</sup>            | $I_{D,pulse}$  | -      | -    | 112  | A    | $T_C = 25\text{ °C}$                                                      |
| Avalanche energy, single pulse                | $E_{AS}$       | -      | -    | 796  | mJ   | $I_D = 6.6\text{ A}, V_{DD} = 50\text{ V}$<br>(see table 21)              |
| Avalanche energy, repetitive                  | $E_{AR}$       | -      | -    | 1.2  |      | $I_D = 6.6\text{ A}, V_{DD} = 50\text{ V}$                                |
| Avalanche current, repetitive                 | $I_{AR}$       | -      | -    | 6.6  | A    |                                                                           |
| MOSFET dv/dt ruggedness                       | dv/dt          | -      | -    | 50   | V/ns | $V_{DS} = 0 \dots 480\text{ V}$                                           |
| Gate source voltage                           | $V_{GS}$       | -20    | -    | 20   | V    | static                                                                    |
|                                               |                | -30    |      | 30   |      | AC ( $f > 1\text{ Hz}$ )                                                  |
| Power dissipation for TO-220, TO-247, TO-263  | $P_{tot}$      | -      | -    | 278  | W    | $T_C = 25\text{ °C}$                                                      |
| Power dissipation for TO-220 FullPAK          | $P_{tot}$      | -      | -    | 35   |      |                                                                           |
| Operating and storage temperature             | $T_j, T_{stg}$ | -55    | -    | 150  | °C   |                                                                           |
| Mounting torque TO-220, TO-247                |                | -      | -    | 60   | Ncm  | M3 and M3.5 screws                                                        |
| Mounting torque TO-220 FullPAK                |                |        |      | 50   |      | M2.5 screws                                                               |
| Continuous diode forward current              | $I_S$          | -      | -    | 33   | A    | $T_C = 25\text{ °C}$                                                      |
| Diode pulse current <sup>2)</sup>             | $I_{S,pulse}$  | -      | -    | 112  | A    | $T_C = 25\text{ °C}$                                                      |
| Reverse diode dv/dt <sup>3)</sup>             | dv/dt          | -      | -    | 15   | V/ns | $V_{DS} = 0 \dots 400\text{ V}, I_{SD} \leq I_D,$<br>$T_j = 25\text{ °C}$ |
| Maximum diode commutation speed <sup>3)</sup> | di/dt          |        |      | 300  | A/μs | (see table 22)                                                            |

1) Limited by  $T_{j,max}$ . Maximum duty cycle  $D = 0.75$

2) Pulse width  $t_p$  limited by  $T_{j,max}$

3) Identical low side and high side switch with identical  $R_G$

### 3 Thermal characteristics

**Table 3 Thermal characteristics TO-220 (IPP60R099C6), TO-247 (IPW60R099C6)**

| Parameter                                                  | Symbol     | Values |      |      | Unit | Note / Test Condition                 |
|------------------------------------------------------------|------------|--------|------|------|------|---------------------------------------|
|                                                            |            | Min.   | Typ. | Max. |      |                                       |
| Thermal resistance, junction - case                        | $R_{thJC}$ | -      | -    | 0.45 | °C/W | leded                                 |
| Thermal resistance, junction - ambient                     | $R_{thJA}$ | -      | -    | 62   |      |                                       |
| Soldering temperature, wavesoldering only allowed at leads | $T_{sold}$ | -      | -    | 260  | °C   | 1.6 mm (0.063 in.) from case for 10 s |

**Table 4 Thermal characteristics TO-220FullIPAK (IPA60R099C6)**

| Parameter                                                  | Symbol     | Values |      |      | Unit | Note / Test Condition                 |
|------------------------------------------------------------|------------|--------|------|------|------|---------------------------------------|
|                                                            |            | Min.   | Typ. | Max. |      |                                       |
| Thermal resistance, junction - case                        | $R_{thJC}$ | -      | -    | 3.6  | °C/W | leded                                 |
| Thermal resistance, junction - ambient                     | $R_{thJA}$ | -      | -    | 80   |      |                                       |
| Soldering temperature, wavesoldering only allowed at leads | $T_{sold}$ | -      | -    | 260  | °C   | 1.6 mm (0.063 in.) from case for 10 s |

**Table 5 Thermal characteristics TO-263 (IPB60R099C6)**

| Parameter                                               | Symbol     | Values |      |      | Unit | Note / Test Condition                         |
|---------------------------------------------------------|------------|--------|------|------|------|-----------------------------------------------|
|                                                         |            | Min.   | Typ. | Max. |      |                                               |
| Thermal resistance, junction - case                     | $R_{thJC}$ | -      | -    | 0.45 | °C/W | SMD version, device on PCB, minimal footprint |
| Thermal resistance, junction - ambient                  | $R_{thJA}$ | -      | -    | 62   |      |                                               |
|                                                         |            | -      | 35   | -    |      |                                               |
| Soldering temperature, wave- & reflow soldering allowed | $T_{sold}$ | -      | -    | 260  | °C   | reflow MSL1                                   |

1) Device on 40mm\*40mm\*1.5mm one layer epoxy PCB FR4 with 6cm<sup>2</sup> copper area (thickness 70µm) for drain connection. PCB is vertical without air stream cooling.

## 4 Electrical characteristics

Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified.

**Table 6 Static characteristics**

| Parameter                        | Symbol        | Values |      |       | Unit          | Note / Test Condition                                                |
|----------------------------------|---------------|--------|------|-------|---------------|----------------------------------------------------------------------|
|                                  |               | Min.   | Typ. | Max.  |               |                                                                      |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 600    | -    | -     | V             | $V_{GS}=0\text{ V}$ , $I_D=0.25\text{ mA}$                           |
| Gate threshold voltage           | $V_{GS(th)}$  | 2.5    | 3    | 3.5   |               | $V_{DS}=V_{GS}$ , $I_D=1.21\text{ mA}$                               |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | -    | 5     | $\mu\text{A}$ | $V_{DS}=600\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=25\text{ °C}$  |
|                                  |               | -      | 50   | -     |               | $V_{DS}=600\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=150\text{ °C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | -    | 100   | nA            | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                           |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 0.09 | 0.099 | $\Omega$      | $V_{GS}=10\text{ V}$ , $I_D=18.1\text{ A}$ ,<br>$T_j=25\text{ °C}$   |
|                                  |               | -      | 0.23 | -     |               | $V_{GS}=10\text{ V}$ , $I_D=18.1\text{ A}$ ,<br>$T_j=150\text{ °C}$  |
| Gate resistance                  | $R_G$         | -      | 1.6  | -     | $\Omega$      | $f=1\text{ MHz}$ , open drain                                        |

**Table 7 Dynamic characteristics**

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                                        |
|------------------------------------------------------------|--------------|--------|------|------|------|--------------------------------------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                                                              |
| Input capacitance                                          | $C_{iss}$    | -      | 2660 | -    | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=100\text{ V}$ ,<br>$f=1\text{ MHz}$                                            |
| Output capacitance                                         | $C_{oss}$    | -      | 154  | -    |      |                                                                                                              |
| Effective output capacitance, energy related <sup>1)</sup> | $C_{o(er)}$  | -      | 100  | -    |      | $V_{GS}=0\text{ V}$ ,<br>$V_{DS}=0\ldots 480\text{ V}$                                                       |
| Effective output capacitance, time related <sup>2)</sup>   | $C_{o(tr)}$  | -      | 500  | -    |      | $I_D=\text{constant}$ , $V_{GS}=0\text{ V}$<br>$V_{DS}=0\ldots 480\text{ V}$                                 |
| Turn-on delay time                                         | $t_{d(on)}$  | -      | 15   | -    | ns   | $V_{DD}=400\text{ V}$ ,<br>$V_{GS}=13\text{ V}$ , $I_D=18.1\text{ A}$ ,<br>$R_G=1.7\Omega$<br>(see table 20) |
| Rise time                                                  | $t_r$        | -      | 12   | -    |      |                                                                                                              |
| Turn-off delay time                                        | $t_{d(off)}$ | -      | 75   | -    |      |                                                                                                              |
| Fall time                                                  | $t_f$        | -      | 6    | -    |      |                                                                                                              |

1)  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{(BR)DSS}$

2)  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{(BR)DSS}$

**Table 8 Gate charge characteristics**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test Condition                                                                |
|-----------------------|---------------|--------|------|------|------|--------------------------------------------------------------------------------------|
|                       |               | Min.   | Typ. | Max. |      |                                                                                      |
| Gate to source charge | $Q_{gs}$      | -      | 14   | -    | nC   | $V_{DD}=480\text{ V}$ ,<br>$I_D=18.1\text{ A}$ ,<br>$V_{GS}=0\text{ to }10\text{ V}$ |
| Gate to drain charge  | $Q_{gd}$      | -      | 61   | -    |      |                                                                                      |
| Gate charge total     | $Q_g$         | -      | 119  | -    |      |                                                                                      |
| Gate plateau voltage  | $V_{plateau}$ | -      | 5.4  | -    | V    |                                                                                      |

**Table 9 Reverse diode characteristics**

| Parameter                     | Symbol    | Values |      |      | Unit          | Note / Test Condition                                                                              |
|-------------------------------|-----------|--------|------|------|---------------|----------------------------------------------------------------------------------------------------|
|                               |           | Min.   | Typ. | Max. |               |                                                                                                    |
| Diode forward voltage         | $V_{SD}$  | -      | 0.9  | -    | V             | $V_{GS}=0\text{ V}$ , $I_F=18.1\text{ A}$ ,<br>$T_j=25\text{ °C}$                                  |
| Reverse recovery time         | $t_{rr}$  | -      | 580  | -    | ns            | $V_R=400\text{ V}$ , $I_F=18.1\text{ A}$ ,<br>$di_F/dt=100\text{ A}/\mu\text{s}$<br>(see table 22) |
| Reverse recovery charge       | $Q_{rr}$  | -      | 13   | -    | $\mu\text{C}$ |                                                                                                    |
| Peak reverse recovery current | $I_{rrm}$ | -      | 43   | -    | A             |                                                                                                    |

## 5 Electrical characteristics diagrams

Table 10

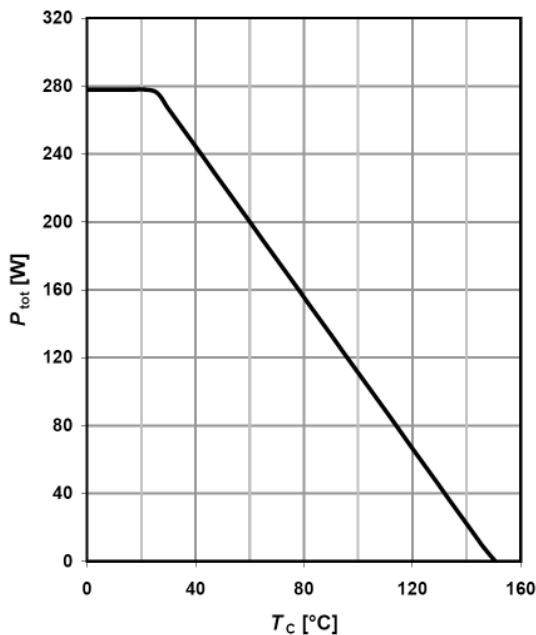
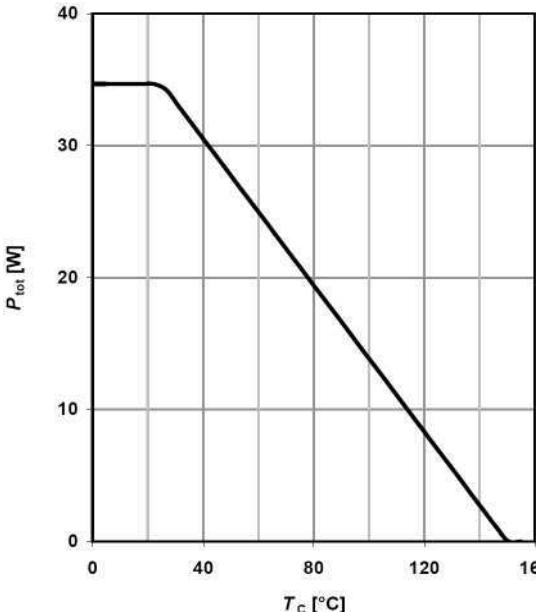
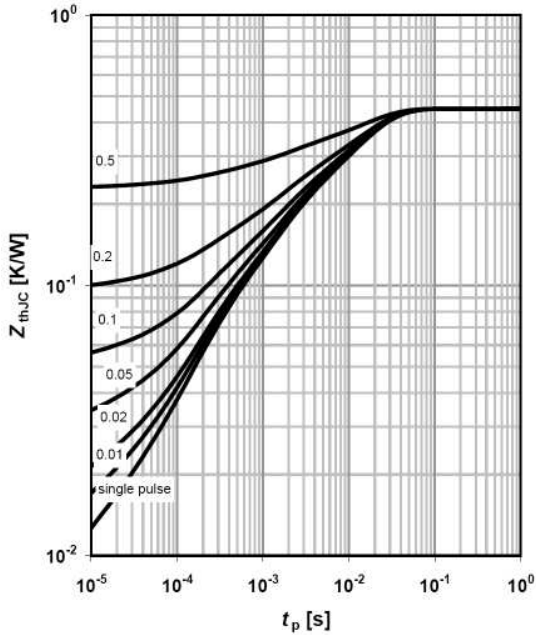
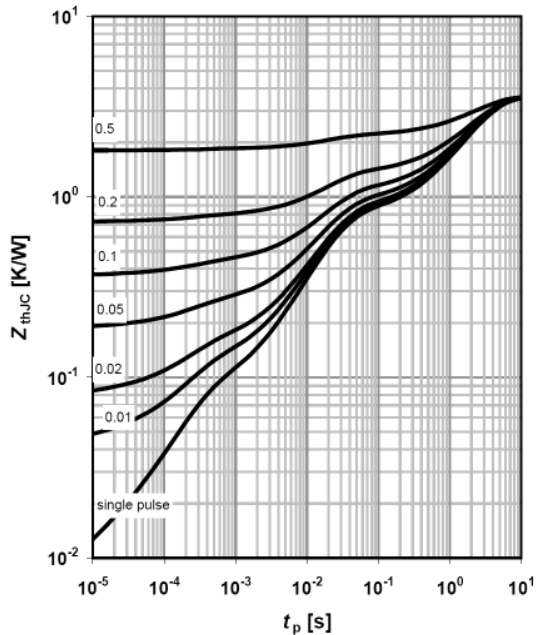
| Power dissipation<br>TO-220, TO-247, TO-263                                        | Power dissipation<br>TO-220 FullPAK                                                 |
|------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
|  |  |
| $P_{\text{tot}} = f(T_c)$                                                          | $P_{\text{tot}} = f(T_c)$                                                           |

Table 11

| Max. transient thermal impedance<br>TO-220, TO-247, TO-263                          | Max. transient thermal impedance<br>TO-220 FullPAK                                   |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |
| $Z_{\text{(thJC)}} = f(t_p)$ ; parameter: $D = t_p / T$                             | $Z_{\text{(thJC)}} = f(t_p)$ ; parameter: $D = t_p / T$                              |

Electrical characteristics diagrams

Table 12

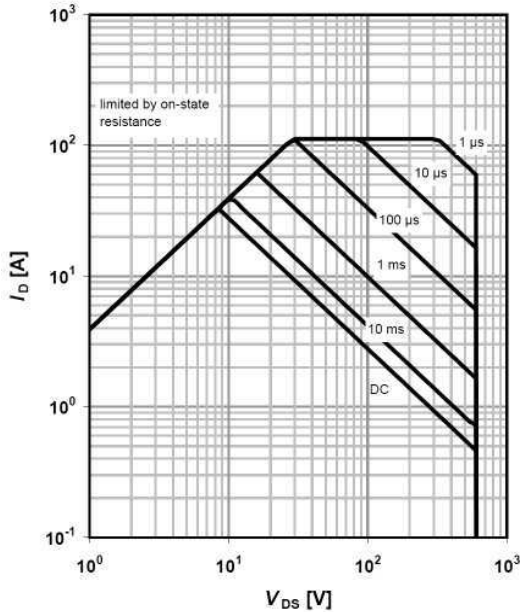
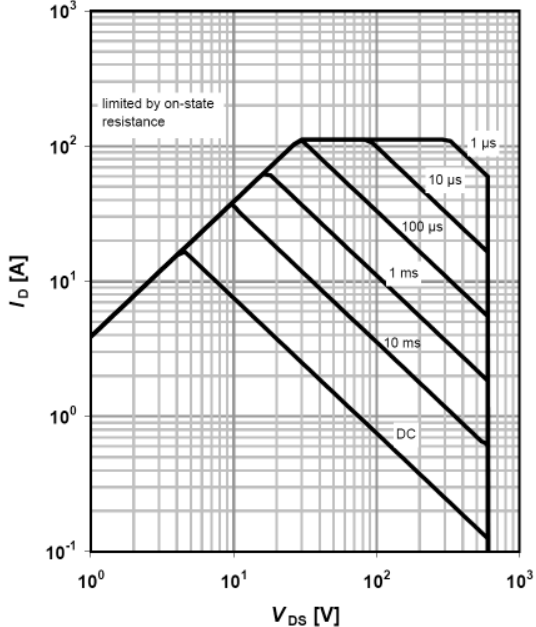
| Safe operating area $T_C=25\text{ °C}$<br>TO-220, TO-247, TO-263                   | Safe operating area $T_C=25\text{ °C}$<br>TO-220 FullPAK                            |
|------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
|  |  |
| $I_D=f(V_{DS}); T_C=25\text{ °C}; D=0; \text{parameter } t_p$                      | $I_D=f(V_{DS}); T_C=25\text{ °C}; D=0; \text{parameter } t_p$                       |

Table 13

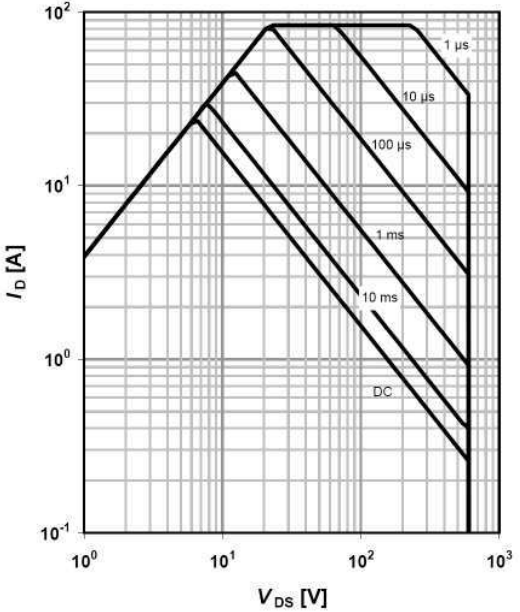
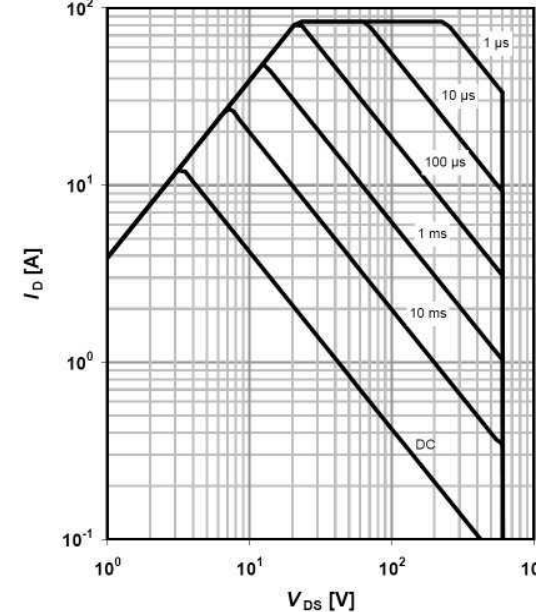
| Safe operating area $T_C=80\text{ °C}$<br>TO-220, TO-247, TO-263                    | Safe operating area $T_C=80\text{ °C}$<br>TO-220 FullPAK                             |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |
| $I_D=f(V_{DS}); T_C=80\text{ °C}; D=0; \text{parameter } t_p$                       | $I_D=f(V_{DS}); T_C=80\text{ °C}; D=0; \text{parameter } t_p$                        |

Table 14

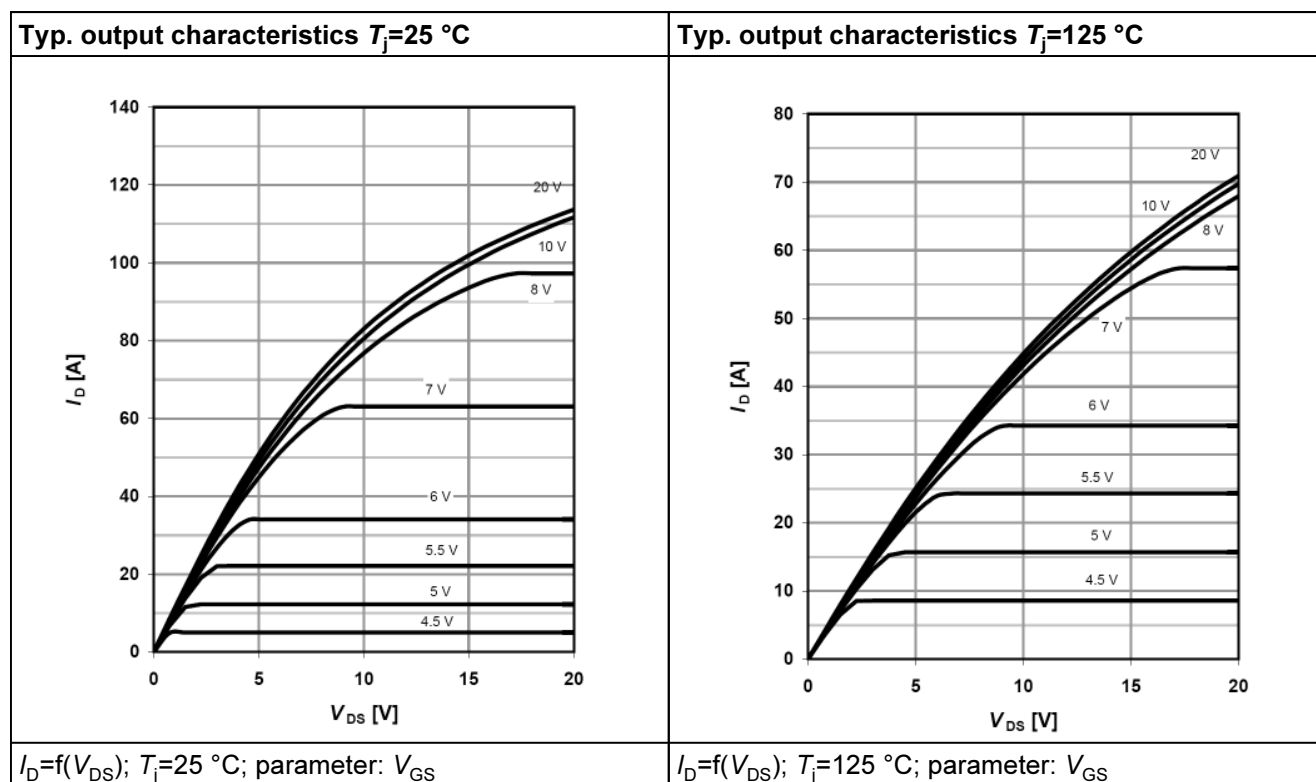


Table 15

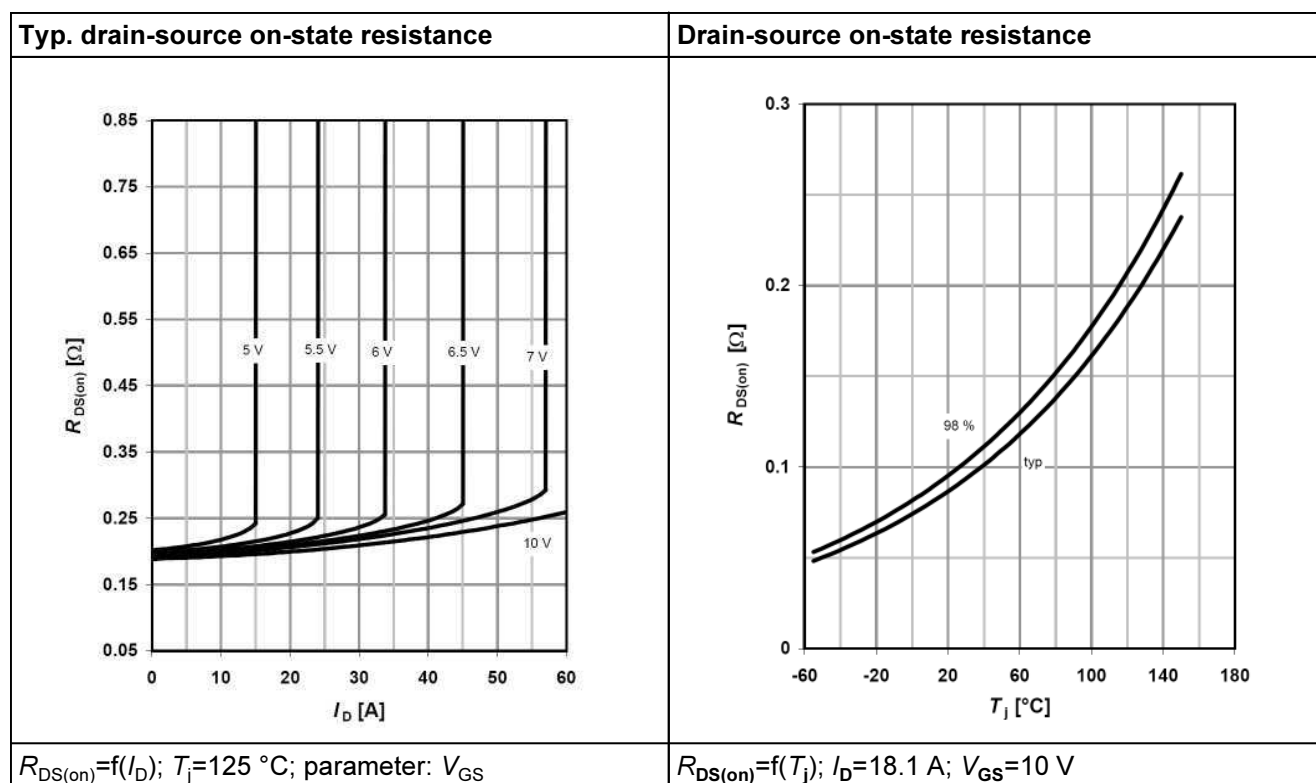


Table 16

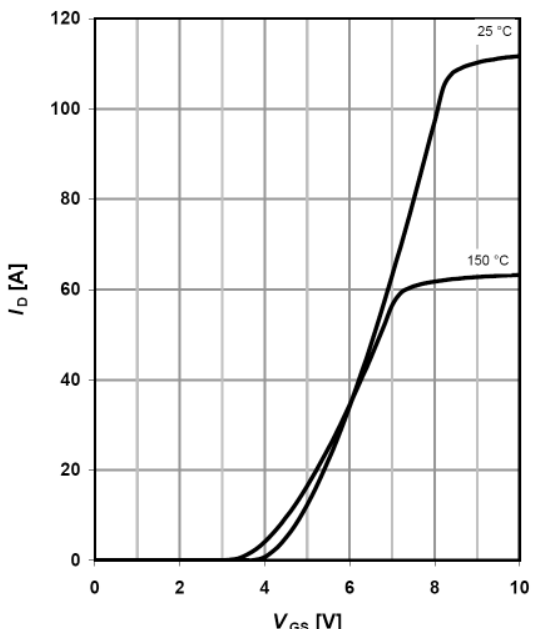
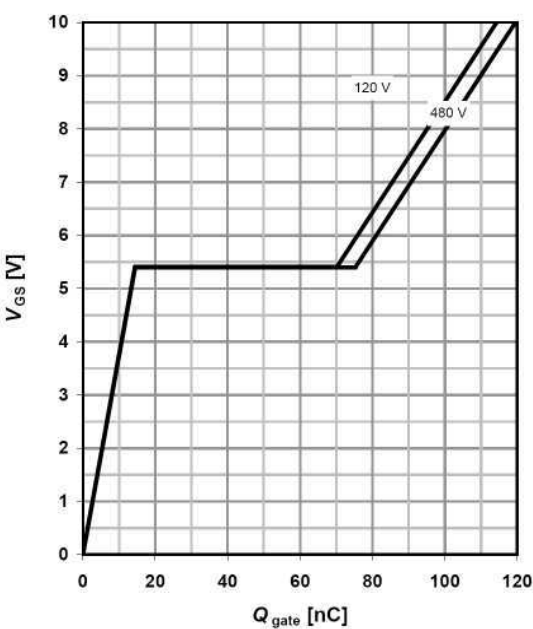
| Typ. transfer characteristics                                                      | Typ. gate charge                                                                    |
|------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
|  |  |
| $I_D = f(V_{GS}); V_{DS} = 20V$                                                    | $V_{GS} = f(Q_{gate}), I_D = 18.1 \text{ A pulsed}$                                 |

Table 17

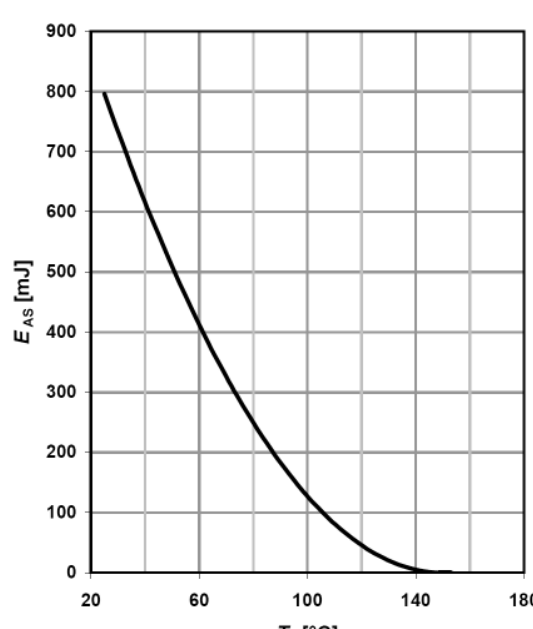
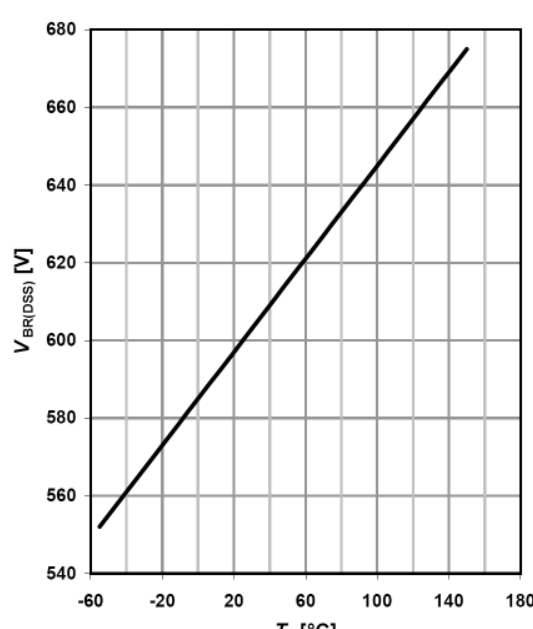
| Avalanche energy                                                                    | Drain-source breakdown voltage                                                       |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |
| $E_{AS} = f(T_j); I_D = 6.6 \text{ A}; V_{DD} = 50 \text{ V}$                       | $V_{BR(DSS)} = f(T_j); I_D = 0.25 \text{ mA}$                                        |

Table 18

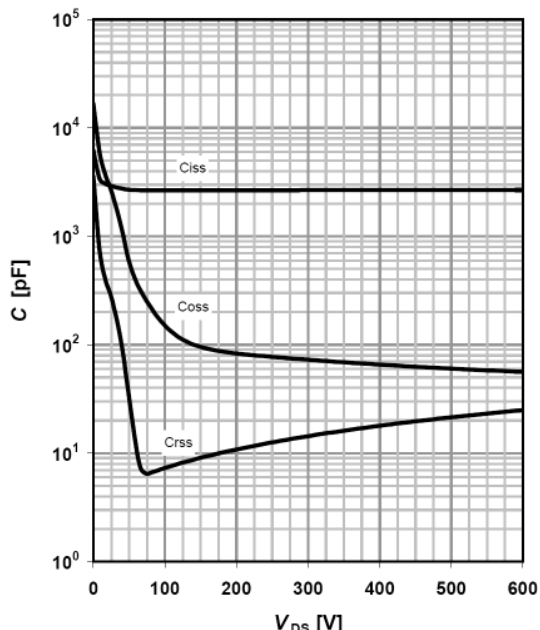
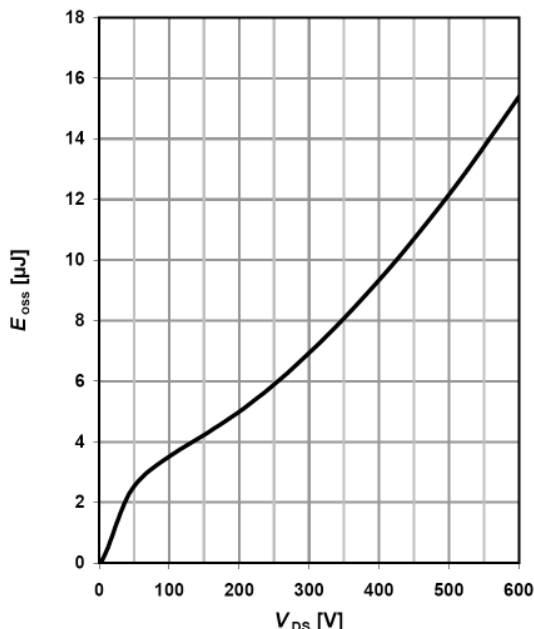
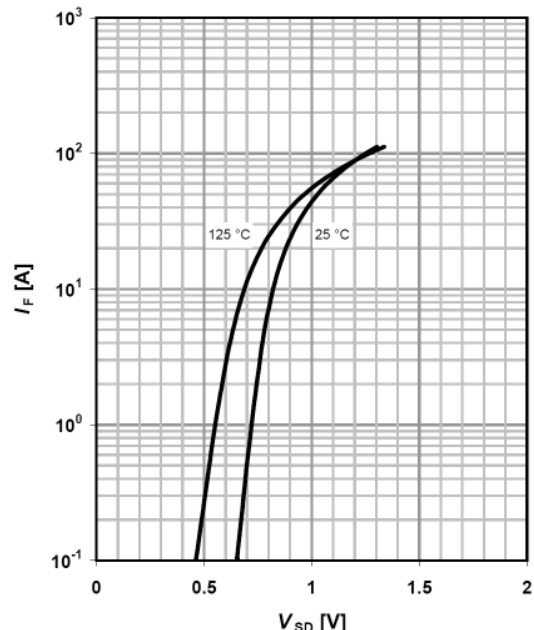
| Typ. capacitances                                                                                                                                             | Typ. $C_{oss}$ stored energy                                                                                                |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|
|  <p><math>C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}</math></p> |  <p><math>E_{oss} = f(V_{DS})</math></p> |

Table 19

| Forward characteristics of reverse diode                                                                                                        |
|-------------------------------------------------------------------------------------------------------------------------------------------------|
|  <p><math>I_F = f(V_{SD}); \text{parameter: } T_j</math></p> |

## 6 Test circuits

Table 20 Switching times test circuit and waveform for inductive load

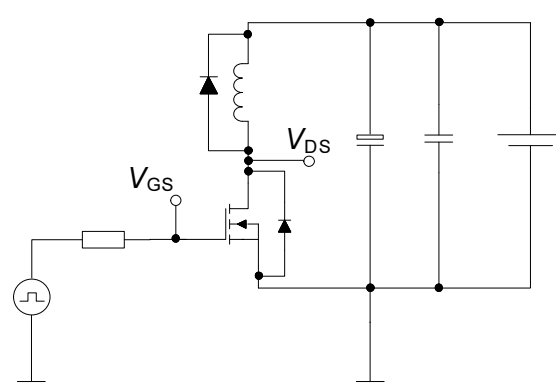
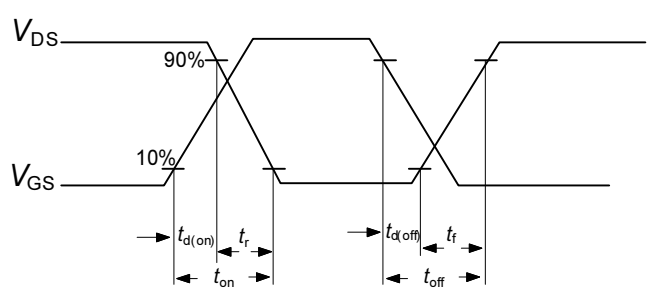
| Switching times test circuit for inductive load                                   | Switching time waveform                                                            |
|-----------------------------------------------------------------------------------|------------------------------------------------------------------------------------|
|  |  |

Table 21 Unclamped inductive load test circuit and waveform

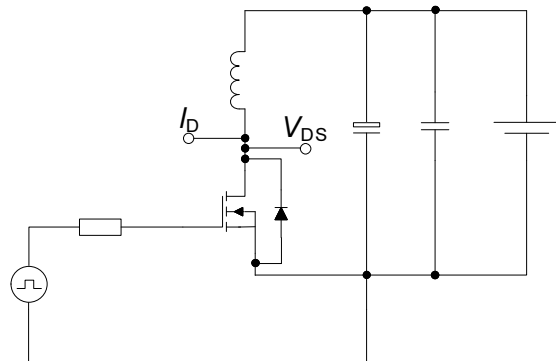
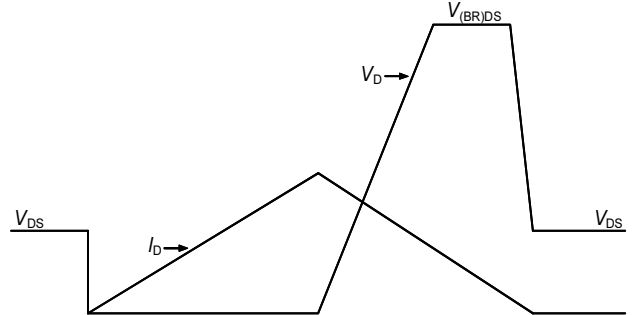
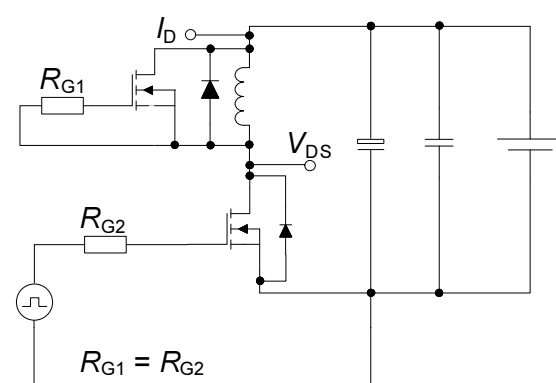
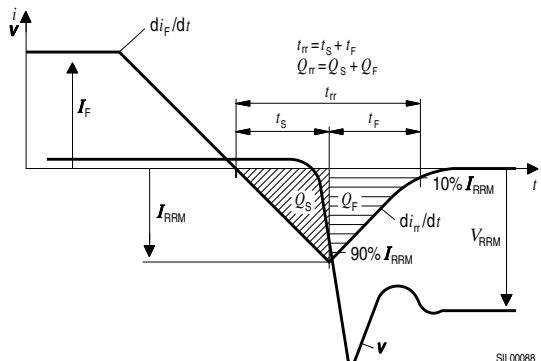
| Unclamped inductive load test circuit                                               | Unclamped inductive waveform                                                         |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

Table 22 Test circuit and waveform for diode characteristics

| Test circuit for diode characteristics                                              | Diode recovery waveform                                                              |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

## 7 Package outlines

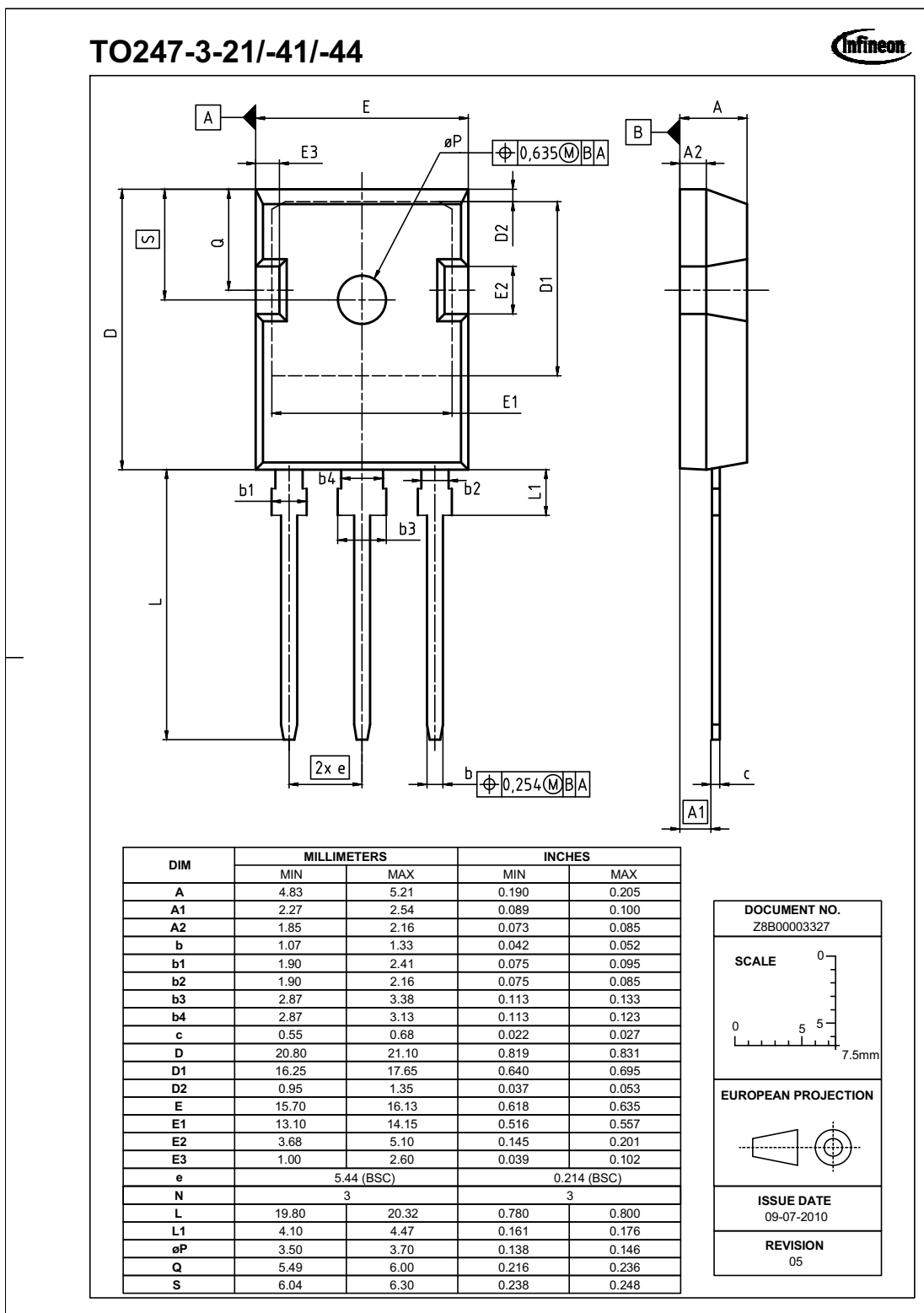


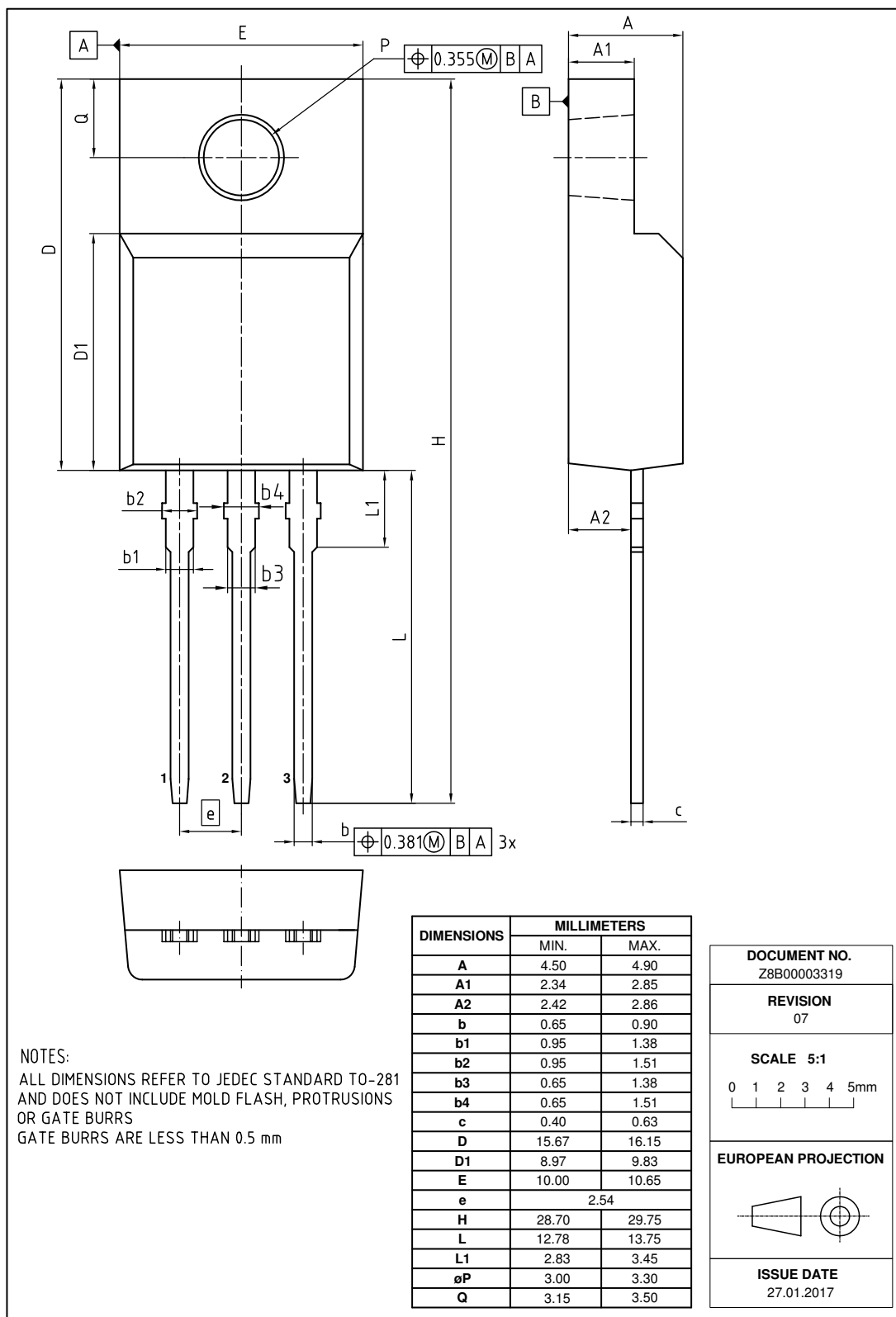
Figure 1 Outlines TO-247, dimensions in mm/inches



| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 4.30        | 4.57  | 0.169  | 0.180 |
| A1  | 1.17        | 1.40  | 0.046  | 0.055 |
| A2  | 2.15        | 2.72  | 0.085  | 0.107 |
| b   | 0.65        | 0.86  | 0.026  | 0.034 |
| b1  | 0.95        | 1.40  | 0.037  | 0.055 |
| b2  | 0.95        | 1.15  | 0.037  | 0.045 |
| b3  | 0.65        | 1.15  | 0.026  | 0.045 |
| c   | 0.33        | 0.60  | 0.013  | 0.024 |
| D   | 14.81       | 15.95 | 0.583  | 0.628 |
| D1  | 8.51        | 9.45  | 0.335  | 0.372 |
| D2  | 12.19       | 13.10 | 0.480  | 0.516 |
| E   | 9.70        | 10.36 | 0.382  | 0.408 |
| E1  | 6.50        | 8.60  | 0.256  | 0.339 |
| e   | 2.54        |       | 0.100  |       |
| e1  | 5.08        |       | 0.200  |       |
| N   | 3           |       | 3      |       |
| H1  | 5.90        | 6.90  | 0.232  | 0.272 |
| L   | 13.00       | 14.00 | 0.512  | 0.551 |
| L1  | -           | 4.80  | -      | 0.189 |
| øP  | 3.60        | 3.89  | 0.142  | 0.153 |
| Q   | 2.60        | 3.00  | 0.102  | 0.118 |



Figure 2 Outlines TO-220, dimensions in mm/inches



**Figure 3** Outline PG-TO-220 FullPAK dimensions in mm

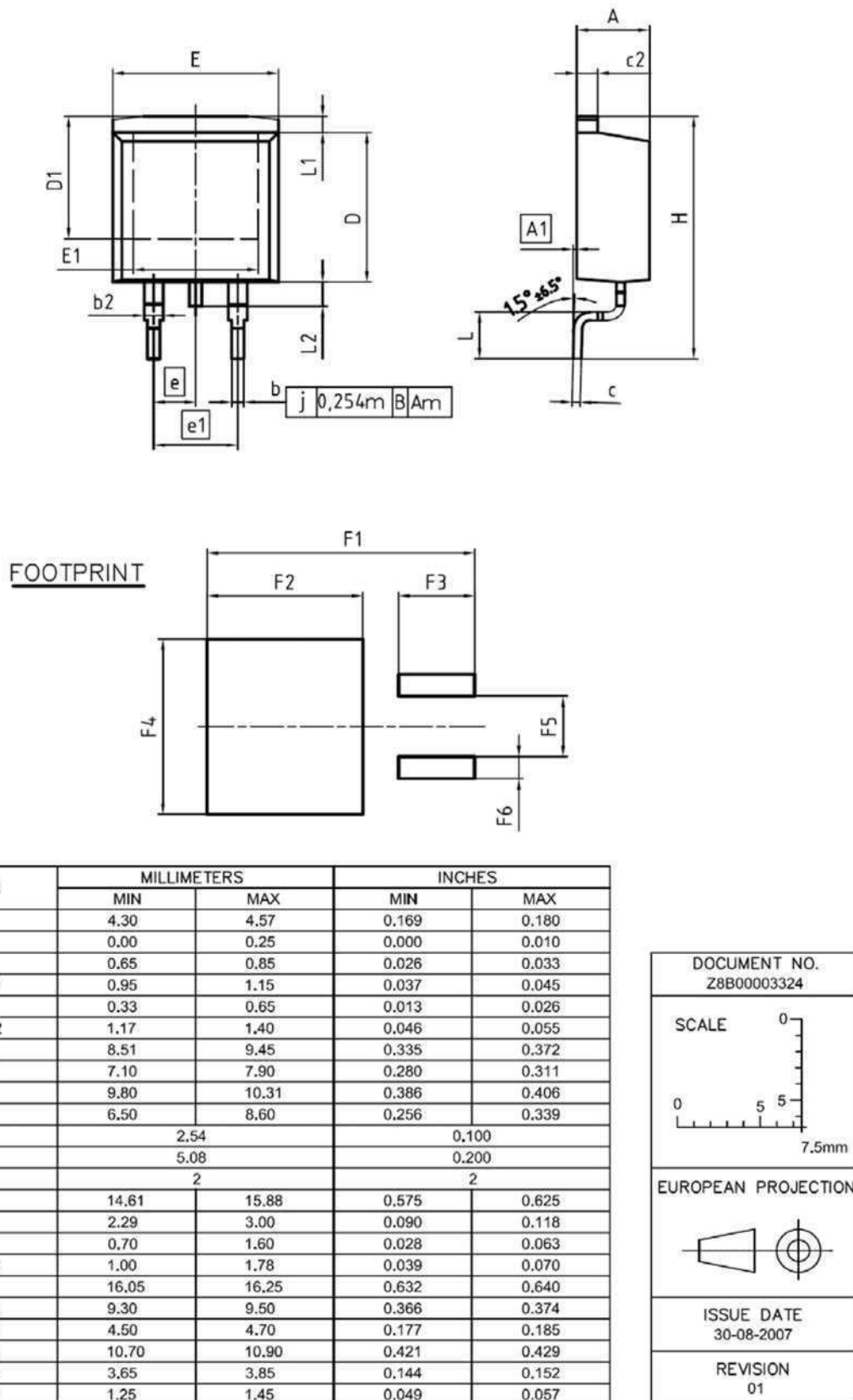


Figure 4 Outlines TO-263, dimensions in mm/inches

## Revision History

IPA60R099C6

**Revision: 2018-03-05, Rev. 2.3**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.3      | 2018-03-05 | Outline PG-TO220 FullPAK update              |

### Trademarks of Infineon Technologies AG

AURIX™, C166™, CanPAK™, CIPOS™, CoolGaN™, CoolMOS™, CoolSET™, CoolSiC™, CORECONTROL™, CROSSAVE™, DAVE™, DI-POL™, DrBlade™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPACK™, EconoPIM™, EiceDRIVER™, eupec™, FCOS™, HITFET™, HybridPACK™, Infineon™, ISOFACE™, IsoPACK™, i-Wafer™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OmniTune™, OPTIGA™, OptiMOS™, ORIGA™, POWERCODE™, PRIMARION™, PrimePACK™, PrimeSTACK™, PROFET™, PRO-SiL™, RASIC™, REAL3™, ReverSave™, SatRIC™, SIEGET™, SiPMOS™, SmartLEWIS™, SOLID FLASH™, SPOC™, TEMPFET™, thinQ!™, TRENCHSTOP™, TriCore™.

Trademarks updated August 2015

### Other Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

### We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to:

[erratum@infineon.com](mailto:erratum@infineon.com)

### Published by

**Infineon Technologies AG**

**81726 München, Germany**

**© 2018 Infineon Technologies AG**

**All Rights Reserved.**

### Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office ([www.infineon.com](http://www.infineon.com)).

### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.